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Patent Application

Inventor(s):

Ho-Yuan Yu

Application No.:

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Group Art Unit:

Filed:

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Examiner:

Title:

METHOD AND STRUCTURE FOR COMPOSITE TRENCH FILL

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
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Foreign Patent or Published Foreign Patent Application

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Examiner	7	Document	Publication	Country or		Sub-	Trans	lation	
Initial	No.	No.	Date	Patent Office	Class	class	Yes	No	ĺ
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Examiner							
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.